Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/520,855	LEE ET AL.	
Examiner	Art Unit	
Cuona O Nauven	2811	

	SEAR	CHED	
Class	Subclass	Date	Examiner
157	77-103	9-18-06	a

See INT	ERFERENC	E SEARCI	HED note
Class	Subclass	Date	Examiner
		·	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EMSTHEPO HTPO	9-18-06	a		